## Insights into the mechanism of enhanced visible-light photocatalytic activity of black phosphorus/BiVO<sub>4</sub> heterostructure: a first-principles study

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1. The optimized geometry of black phosphorus/BiVO<sub>4</sub> heterostructure are shown in Figure S1. Considering four representational high-symmetric stacking patterns: (1) the underlayer of the phosphorene layer directly aligns with and above the top sites of the top O atom of BiVO<sub>4</sub>(001) surface, denoted in the P1 structure (Figure S1 a-b). (2) the upper layer of the phosphorene layer aligns with the top O atom of BiVO<sub>4</sub>(001) surface, denoted the P2 structure(Figure S1 b). (3) the middle-point of the top P-P bond of the phosphorene layer aligns with the top O atom of BiVO<sub>4</sub>(001) surface, denoted the P3 structure (Figure S1 c). (4) the middle-point of the bottom of P-P bond of the phosphorene layer aligns with and above the hollow sites the top O atom of BiVO<sub>4</sub>(001) surface, denoted in the P4 structure (Figure S1 d)

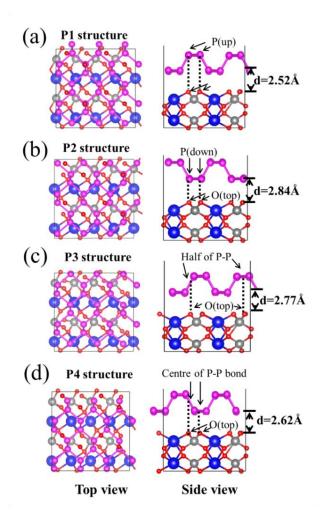


Figure S1: (a) The optimized geometry of black phosphorus/BiVO<sub>4</sub> heterostructure for P1(a), P2(b), P3(c), P4(d) structure, respectively.

2、Relative total energy of the four representational high-symmetric stacking patterns. TheP4 structure demonstrates the lowest energy, which indicate that the P4 structure is mostenergetically favorable.

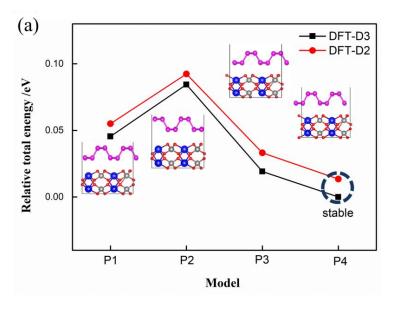


Figure S2: Relative total energy of the four representational high-symmetric stacking patterns calculated by DFT-D3 and DFT-D2 method, respectively.

Method	BP mono	BP bulk	BiVO4 bulk	BiVO <sub>4</sub> (001)	BP/BiVO <sub>4</sub>	Source
photoluminescence (optical gap, eV)	2.0	0.35				Buscema <sup>4</sup>
	2.0-2.1	0.33				Gomez <sup>6</sup>
	1.45					Wang <sup>7</sup>
			2.4			Song <sup>8</sup>
			2.4	2.54		Xi <sup>9</sup>
electrical (mobility gap, eV)	0.98	0.30				Das <sup>5</sup>
Computation (band gap, eV)	2.0	0.3				Tran <sup>1</sup>
	1.94	0.43				Liang <sup>2</sup>
	1.51	0.36				Qiao <sup>12</sup>
	1.01	0.31				Liu <sup>3</sup>
	1.07	0.43				Gomez <sup>6</sup>
			2.16			Walsh <sup>10</sup>
			2.09/2.41(HSE)			Wadnerkar <sup>11</sup>
Computation (band gap, eV)	0.98	0.15	2.05	2.52	0.76	this work
	1.51	0.50	2.60	2.96	0.89	

## Table 1. Band gaps of the referred materials.

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